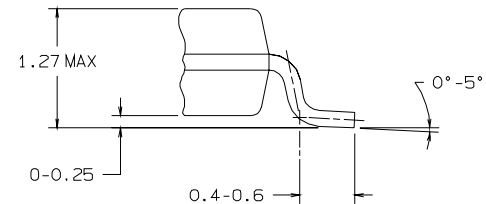
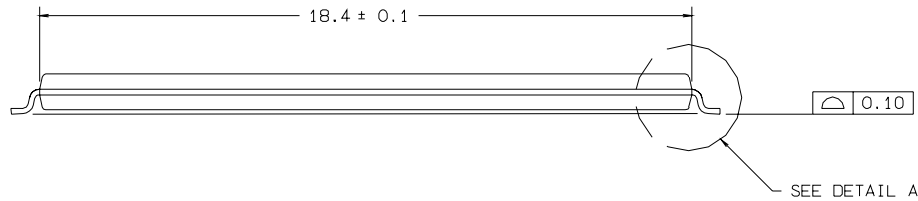
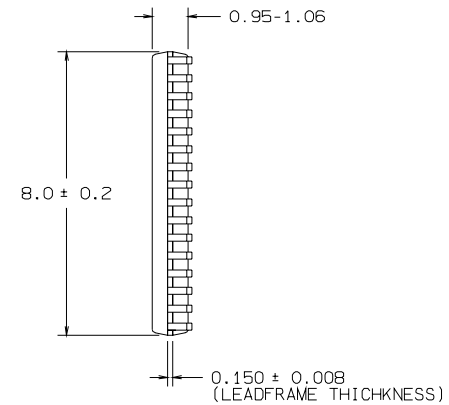
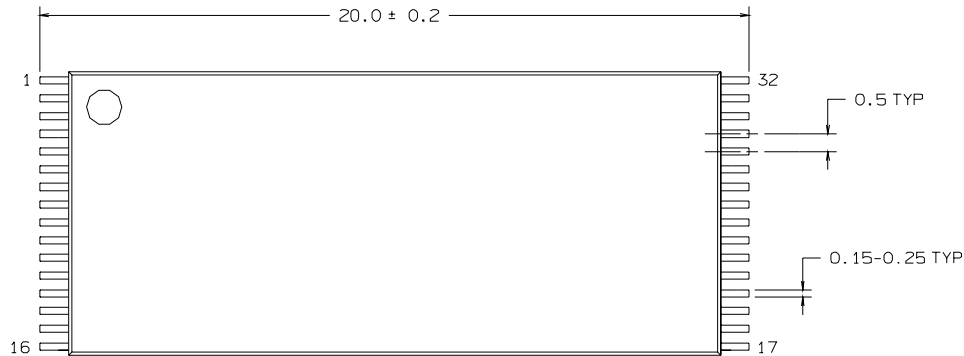


REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	0904B	03/02/92	MS/CC
B	COPLANARITY 0.10 WAS 0.065; DIM 8.0±0.2 WAS 8.0±0.1; DIM 0.95-1.06 WAS 1.01±0.05; DELETE DIM (0.43); DET A: ANGLE 0°-5° WAS 1°-5°; DIM 0-0.25 WAS 0.065-0.250.	10175	11/30/93	MS/



DETAIL A  
TYPICAL

DIMENSIONS ARE IN MILLIMETERS

APPROVALS	DATE	NATIONAL SEMICONDUCTOR CORPORATION		
DRAWN MARTA SUCHY	03/02/92	2900 Semiconductor Drive, Santa Clara, CA 95052-8090		
DF TG. CHK.		TSOP, EIAJ TYPE I, 8 X 20 mm, 32 LEAD		
ENGR. CHK.				
APPROVAL				
PROJECTION	SCALE	SIZE	DRAWING NUMBER	REV
	N/A	C	MKT-MBH32A	B
DO NOT SCALE DRAWING		SHEET 1 OF 1		